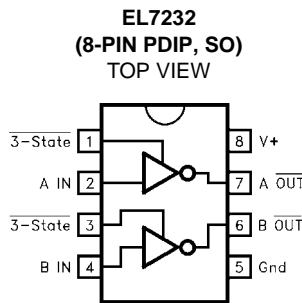


**Dual Channel, High Speed, High Current Line Driver w/3-State**

**élantec** The EL7232 3-state drivers are particularly well suited for ATE and microprocessor based applications.

The low quiescent power dissipation makes this part attractive in battery applications. The 2A peak drive capability, makes the EL7232 an excellent choice when driving high speed capacitive lines, as well. The input circuitry provides level shifting from TTL levels to the supply rails. The EL7232 is available in 8-pin PDIP and 8-lead SO packages.

**Pinout**



Manufactured under U.S. Patent Nos. 5,334,883, #5,341,047

**Features**

- 3-State output
- 3V and 5V input compatible
- Clocking speeds up to 10MHz
- 20ns Switching/delay time
- 2A Peak drive
- Low, matched output impedance—5Ω
- Low quiescent current — 2.5mA
- Wide operating voltage — 4.5V-16V

**Applications**

- Parallel bus line drivers
- EPROM and PROM programming
- Motor controls
- Charge pumps
- Sampling circuits
- Pin drivers
- Bridge circuits

**Ordering Information**

PART NUMBER	TEMP. RANGE	PACKAGE	PKG. NO.
EL7232CN	-40°C to +85°C	8-Pin PDIP	MDP0031
EL7232CS	-40°C to +85°C	8-Pin SO	MDP0027

**Truth Table**

3-STATE	INPUT	OUTPUT
1	0	1
1	1	0
0	0	Open
0	1	Open

**Absolute Maximum Ratings** ( $T_A = 25^\circ\text{C}$ )

Supply (V+ to Gnd) . . . . .	16.5V	Operating Junction Temperature . . . . .	125°C
Input Pins . . . . .	-0.3V to +0.3V above V+	Power Dissipation	
Combined Peak Output Current . . . . .	.4A	SOIC . . . . .	.570mW
Storage Temperature Range . . . . .	-65°C to +150°C	PDIP . . . . .	.1050mW
Ambient Operating Temperature . . . . .	-40°C to +85°C		

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

IMPORTANT NOTE: All parameters having Min/Max specifications are guaranteed. Typical values are for information purposes only. Unless otherwise noted, all tests are at the specified temperature and are pulsed tests, therefore:  $T_J = T_C = T_A$

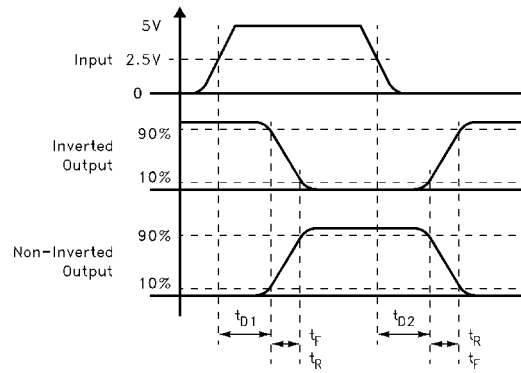
**DC Electrical Specifications**  $T_A = 25^\circ\text{C}$ ,  $V = 15\text{V}$  unless otherwise specified

PARAMETER	DESCRIPTION	TEST CONDITIONS	MIN	TYP	MAX	UNITS
<b>INPUT</b>						
$V_{IH}$	Logic "1" Input Voltage		2.4			V
$I_{IH}$	Logic "1" Input Current	@V+		0.1	10	$\mu\text{A}$
$V_{IL}$	Logic "0" Input Voltage				0.8	V
$I_{IL}$	Logic "0" Input Current	@0V		0.1	10	$\mu\text{A}$
$V_{HVS}$	Input Hysteresis			0.3		V
<b>OUTPUT</b>						
$R_{OH}$	Pull-Up Resistance	$I_{OUT} = -100\text{ mA}$		3	6	$\Omega$
$R_{OL}$	Pull-Down Resistance	$I_{OUT} = +100\text{ mA}$		4	6	$\Omega$
$I_{OFF}$	3-State Output Leakage	$V_{OUT} = V+$ $V_{OUT} = 0V$	0.2		10	$\mu\text{A}$
$I_{PK}$	Peak Output Current	Source Sink		2.0 2.0		A
$I_{DC}$	Continuous Output Current	Source/Sink	100			mA
<b>POWER SUPPLY</b>						
$I_S$	Power Supply Current	Inputs High		1	2.5	mA
$V_S$	Operating Voltage		4.5		16	V

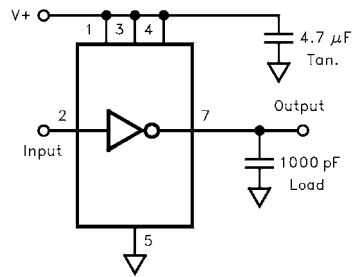
**AC Electrical Specifications**  $T_A = 25^\circ\text{C}$ ,  $V = 15\text{V}$  unless otherwise specified

PARAMETER	DESCRIPTION	TEST CONDITIONS	MIN	TYP	MAX	UNITS
<b>SWITCHING CHARACTERISTICS</b>						
$t_R$	Rise Time	$C_L = 500\text{pF}$ $C_L = 1000\text{pF}$		7.5 10		ns
$t_F$	Fall Time	$C_L = 500\text{pF}$ $C_L = 1000\text{pF}$		10 13	20	ns
$t_{D-ON}$	Turn-On Delay Time			18	25	ns
$t_{D-OFF}$	Turn-Off Delay Time			20	25	ns

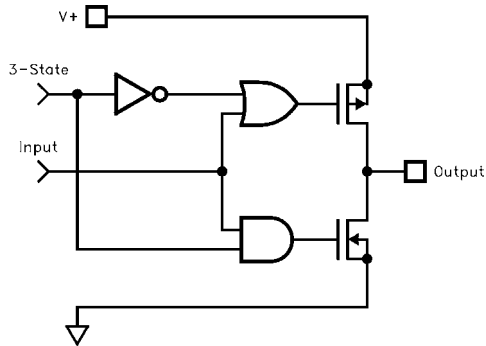
**Timing Table**



**Standard Test Configuration**

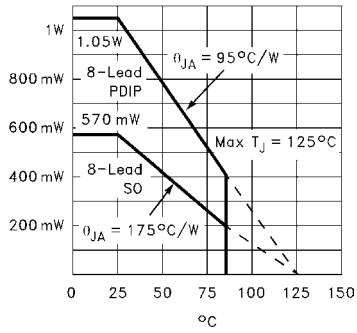


**Simplified Schematic**

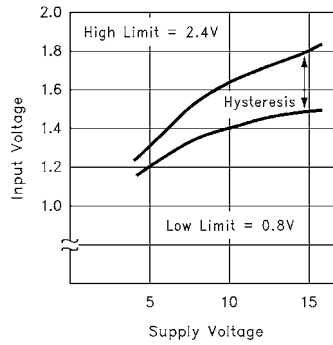


Typical Performance Curves

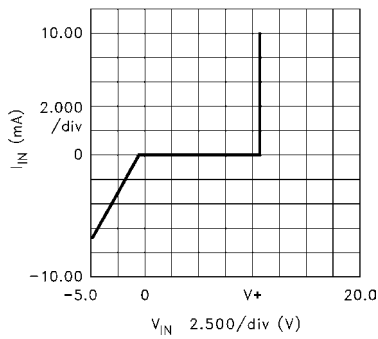
Max Power/Derating Curves



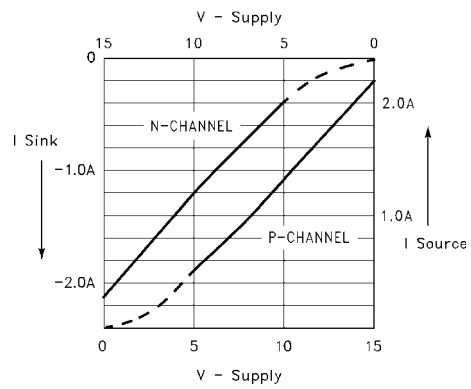
Switch Threshold vs Supply Voltage



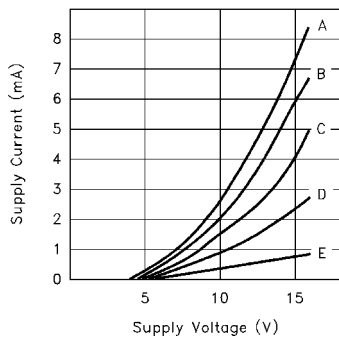
Input Current vs Voltage



Peak Drive vs Supply Voltage



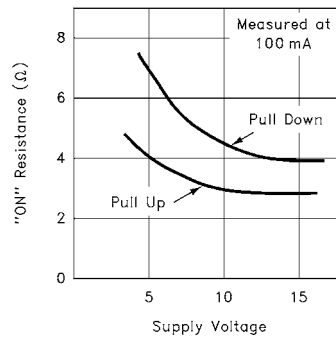
Quiescent Supply Current



CASE:

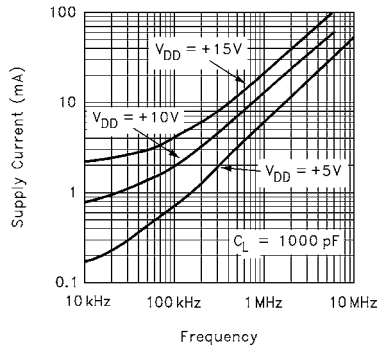
A	ALL INPUTS GND
B	3 INPUTS GND
C	2 INPUTS GND
D	1 INPUTS GND
E	ALL INPUTS V+

"ON" Resistance vs Supply Voltage

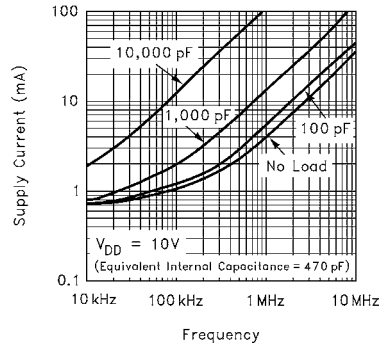


Typical Performance Curves (Continued)

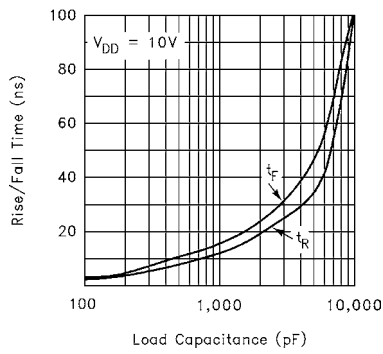
Average Supply Current vs Voltage and Frequency



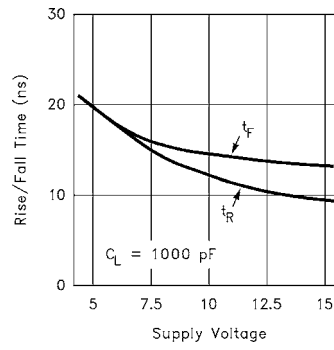
Average Supply Current vs Capacitive Load



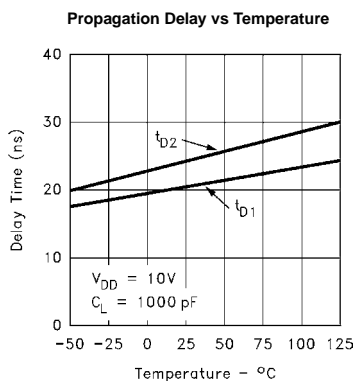
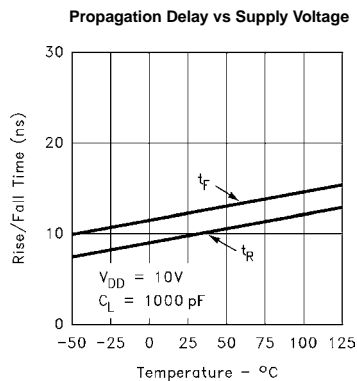
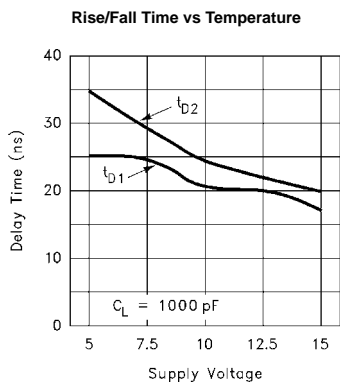
Rise/Fall Time vs Load



Rise/Fall Time vs Supply Voltage



Typical Performance Curves (Continued)



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